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(12) **United States Design Patent** (10) **Patent No.:** **US D922,283 S**
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(54) **INSTRUMENT CLUSTER WITH DISPLAYED IMAGE DESIGN**

(71) Applicant: **Hyundai Mobis Co., Ltd.**, Seoul (KR)

(72) Inventors: **Bo Young Park**, Seongnam-si (KR);
Hyung Soo Kim, Seongnam-si (KR);
Min Hee Kim, Yongin-si (KR); **Jin Yung Bae**, Yongin-si (KR)

(73) Assignee: **Hyundai Mobis Co., Ltd.**, Seoul (KR)

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(30) **Foreign Application Priority Data**

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(52) **U.S. Cl.**
USPC **D12/192**

(58) **Field of Classification Search**

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D10/46, 98, 102-103, 122-12; D23/324
CPC B60H 1/34; B60H 1/3407; B60H 1/3414;
B60H 1/3421; B60H 1/3428; B60H
1/3435; B60H 1/3442; B60H 1/345;
B60H 1/3457; B60H 2001/3464; B60H
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See application file for complete search history.

(56) **References Cited**

U.S. PATENT DOCUMENTS

9,403,489	B2 *	8/2016	Angeletti		B60R 11/0241
D778,250	S *	2/2017	Owens		D14/129
D792,362	S *	7/2017	Maxwell		D14/130
D815,002	S *	4/2018	Niemiec		D12/192
D839,158	S *	1/2019	Buttery		D12/192
D840,304	S *	2/2019	Kang		D12/192
D849,622	S *	5/2019	Woodhouse		D12/192
D856,880	S *	8/2019	Tomasson		D12/192
D867,948	S *	11/2019	Engelmann		D12/192
2014/0125876	A1 *	5/2014	Nakayama		H04N 5/64 348/837
2015/0001870	A1 *	1/2015	Parcher		B60K 35/00 296/1.07
2017/0274773	A1 *	9/2017	Woodhouse		B60K 35/00
2017/0315354	A1 *	11/2017	Park		G02B 27/0149

* cited by examiner

Primary Examiner — Katrina A Betton

(74) *Attorney, Agent, or Firm* — H.C. Park & Associates, PLC

(57) **CLAIM**

The ornamental design for an instrument cluster with displayed image design, as shown and described.

DESCRIPTION

FIG. 1 is a front view of an instrument cluster with displayed image design showing our new design; and, FIG. 2 is an enlarged view of FIG. 1.

The broken lines shown in FIG. 1 illustrate portions of the instrument cluster that form no part of the claimed design.

1 Claim, 1 Drawing Sheet

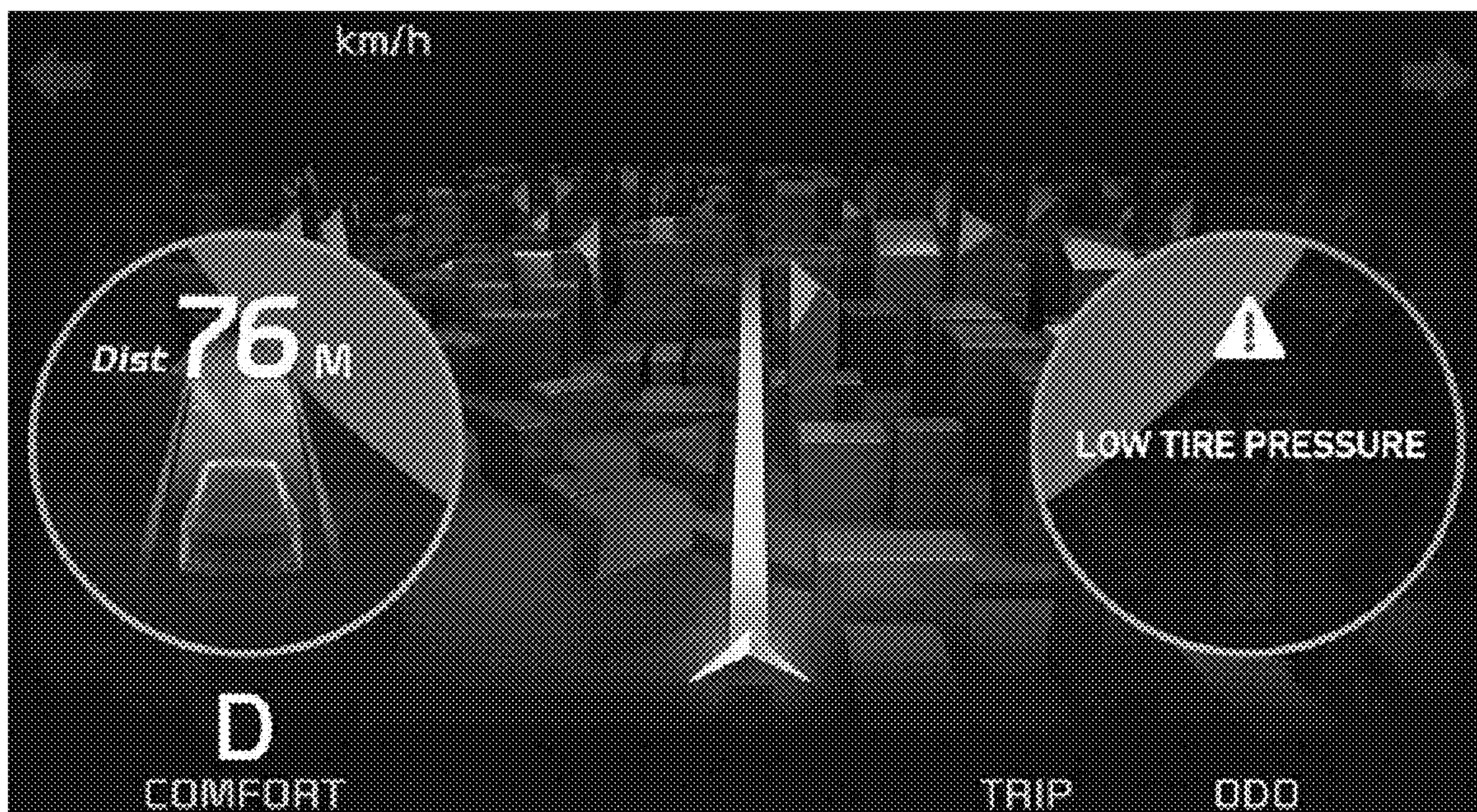


FIG. 1

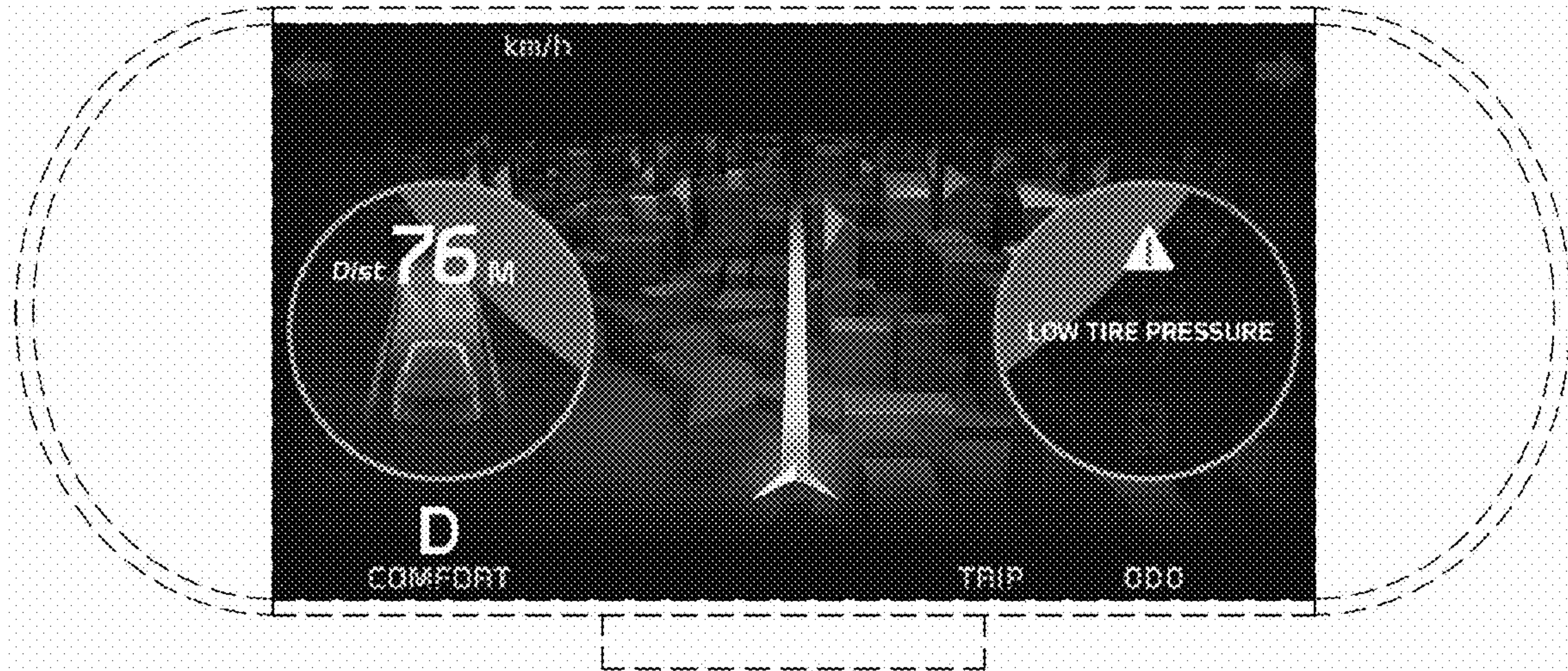


FIG. 2

